

**3M™ IDC Ribbon Cable Socket**

**Series 891**

**Product Specification 78-5102-0022-0**

**Released: 09-27-11**



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## Table of Contents

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Section	Page
<b>1. Scope .....</b>	<b>3</b>
<b>2. 3M Customer Documents .....</b>	<b>3</b>
<b>3. Performance and Test Descriptions .....</b>	<b>3</b>
<b>4. Requirements Overview.....</b>	<b>3</b>
<b>5. Electrical.....</b>	<b>4</b>
<b>6. Mechanical.....</b>	<b>4</b>
<b>7. Physical.....</b>	<b>4</b>
<b>8. Environmental.....</b>	<b>5</b>
<b>9. Test Sequence.....</b>	<b>5</b>
<b>10. Figures.....</b>	<b>6-7</b>
<b>11. Agency Listings.....</b>	<b>8</b>
<b>Important Notice .....</b>	<b>8</b>

## 1. Scope

This document summarizes test methods, test conditions and product performance requirements for the 3M 891XX-0X0X and D891XX-0X0X socket. Listings of materials, finishes, test conditions, and test standards are included in this specification. In the event of conflict between this specification and any documents listed below, the listed documentation supersedes this specification.

## 2. 3M Documents

78-5100-0449-8 TS-0449, Technical Data Sheet for IDC Ribbon Cable Socket, 891 Series  
78-5100-2243-3 TS-2243, Technical Data Sheet for IDC Ribbon Cable Socket, D89 Series  
34-7029-6396-7 3443-107N 3M™ Locator Plate Instructions

## 3. Performance and Test Description

Unless otherwise specified, all primary qualification tests shall be performed on 89150-0001 (30μ" Au) sockets, and all current rating tests shall be performed on 89160-0103 (30μ" Au) sockets. Both sets of tests shall be mated to straight 30μ" gold 3M™ headers and performed using 26 and 28 AWG stranded cable at ambient environmental conditions per EIA-364. Unless otherwise specified, all values and limits are typical of those obtained by qualification testing of the subject product. All specifications are subject to revision and change without notice from 3M.

## 4. Requirements Overview

### 4.1 Ratings

Dielectric withstanding voltage: 500 VAC<sub>RMS</sub> at sea level

Current: ( EIA-364-070 method 2, 30°C maximum temperature rise. )

	1 Line	6* Lines	All Lines
28 AWG	3.00	1.75	1.25
26 AWG	3.50	2.25	1.50

Temperature: -55°C to +105°C

Insulation resistance: >1 x10<sup>9</sup>Ω at 500 VDC

\*Lines are adjacent in 2x3 configuration

### 4.2 Materials

Socket

Insulation: Glass Filled Polyester PBT

Strain Relief: Plastic

IDC Contact: Phosphor Bronze

### 4.3 Finishes

Plating:

Nickel: 50 - 150 μ inches, ASTM B689-97, SAE AMS-QQ-N-290 (891 Series)

Nickel: 30 - 150 μ inches (D89 Series)

Gold - Contact: 30 μ inches, MIL-G-45204 Type II, Grade C (891 Series)

15 μ inches, MIL-G-45204 Type II, Grade C (D89 Series)

### 4.4 Regulatory Compliance

See the Regulatory Information Appendix (RIA) in the "RoHS compliance" section of [www.3Mconnectors.com](http://www.3Mconnectors.com) for compliance information. See customer drawings for regulatory specifics on each connector.

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**5. Electrical**

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method	
Dielectric Withstanding Voltage	500	VAC <sub>RMS</sub>	Measured between adjacent and opposing contacts. No disruptive discharge during 1 minute duration. Sea level with 70% relative humidity.	EIA-364-20F Method A Test Condition I	
Current rating	28 AWG	Amperes	Wire gage.	EIA-364-70A Method 2	
	3.00		26 AWG		1 line driven. 30°C temp. rise. 20% derated.
	2.00		2.75		6 lines driven. 30°C temp. rise. 20% derated.
	1.25		1.50		All line driven. 30°C temp. rise. 20% derated.
Low Level Connection Resistance	<10	Milliohms	10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-23C	
Insulation Resistance	>1 x 10 <sup>9</sup>	Ohms	Measured between adjacent and opposing contacts. 500 VDC for 1 minute duration.	EIA-364-21F	

**6. Mechanical**

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method
Vibration	≤10	ns	Mated connectors shall exhibit no discontinuities greater than specified. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-28F Condition V, Table 2, Cond A, 1.5 hrs
Physical Shock	≤10	ns	Mated connectors shall exhibit no discontinuities greater than specified. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-27B Test Cond. C
Mating Force / Contact	0.5 max	lbs	Mated to a .025" square pin. (Insertion Force)	EIA-364-13E Method A
Unmating Force / Contact	0.075 min	lbs	Mated to a .025" square pin. (Withdrawl Force)	EIA-364-13E Method A
Contact Wiper Normal Force	≥100	g	Displacement equivalent to mating with a .0245" square pin. Test at end of sequence C.	EIA-364-04B
Latch Retention Force	30 min	lbs	Retention force of 2 latches on header, mated to socket. Straight pull on cable.	N/A
Durability (with Environmental)	50- 30 μ" 25- 15 μ"	Mating cycles	10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-09C

**7. Physical**

Description or Parameter	Values & Limits	Units	Requirement or Conditions	Test Standard or Method
Visual	na	na	No defects such as deformation, blister, damage, crack, etc.	EIA-364-18A
Plating Thickness Nickel Gold	50-150 30 15	Microinches	Average of random measurements from any 3 lots.	EIA-364-48

**8. Environmental**

Description or parameter	Values & limits	Units	Requirement or conditions	Test Standard or method
Temperature Life (Thermal Aging)	105	degrees C	1000 hours. No physical abnormalities . 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-17C Method A Condition 4
Humidity	10	24 hr cycles	25-65 C / 90-98%RH with -10 degree C subcycles. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-31F Method IV Fig 1
Thermal Shock	5	cycles	-55 to +105 degrees C. No evidence of mechanical damage. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-32G Method A, Test Cond. VII
Salt Spray	5	% NaCl	48 hours. 10 milliohm maximum ΔR contact resistance per mated interface throughout testing.	EIA-364-26C Test Cond. B

**9. Test Sequence**

**9.1 Sequenced Tests**

**TEST FLOW**

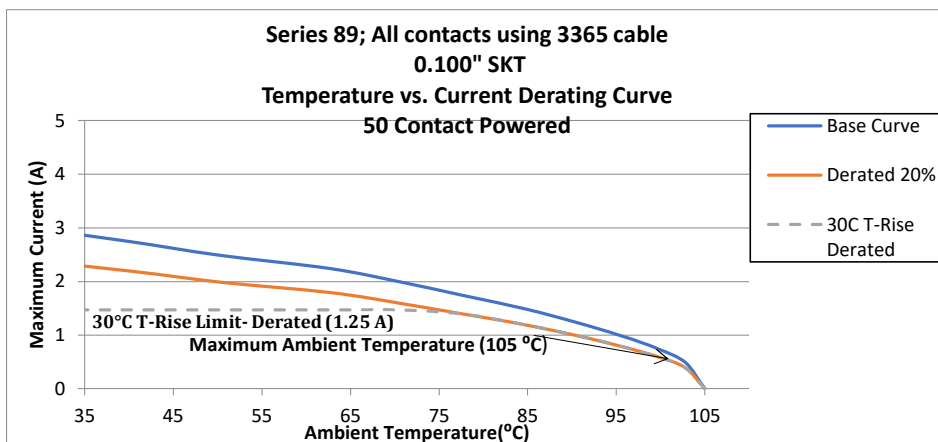
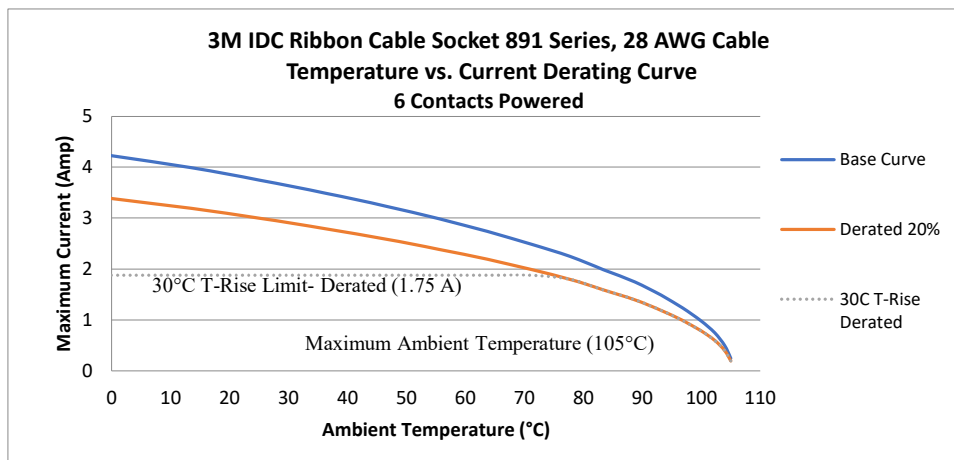
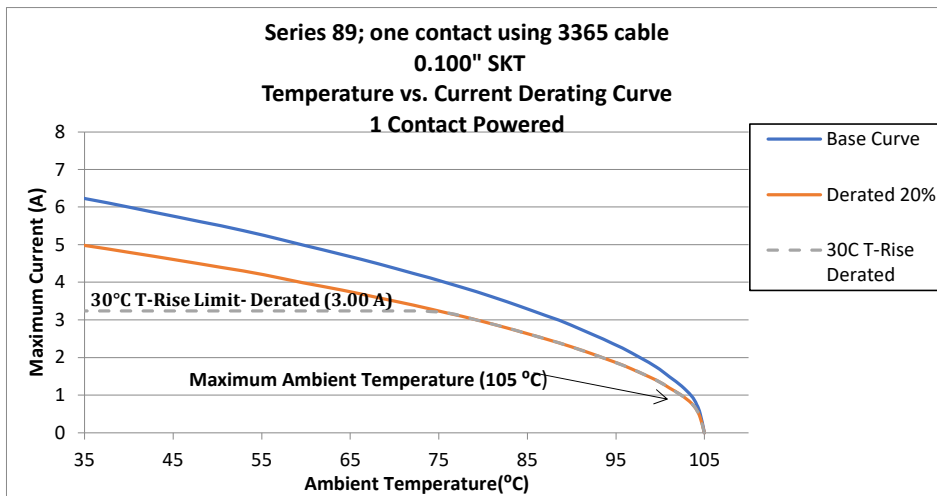
Test	Sequence Numbers for Test Group				
	A	B	C	D	E
Visual				1	1
Low Level Connection Resistance (LLCR)	1,3,5	1,3,5,7	1,3	2,4,6	2,4,6
Vibration				3	
Physical Shock				5	
Durability (with Environmental)		2			3
Temperature Life (Thermal Aging)			2		
Humidity	4	6			
Thermal Shock	2	4			
Salt Spray					5
Contact Wiper Normal Force			4		
Number of Samples (Connectors)	20	6	20	20	10

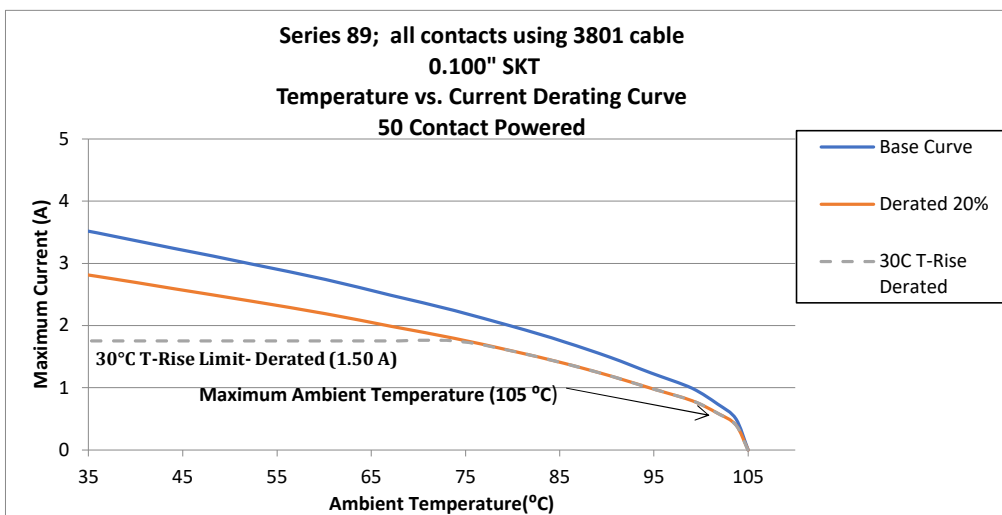
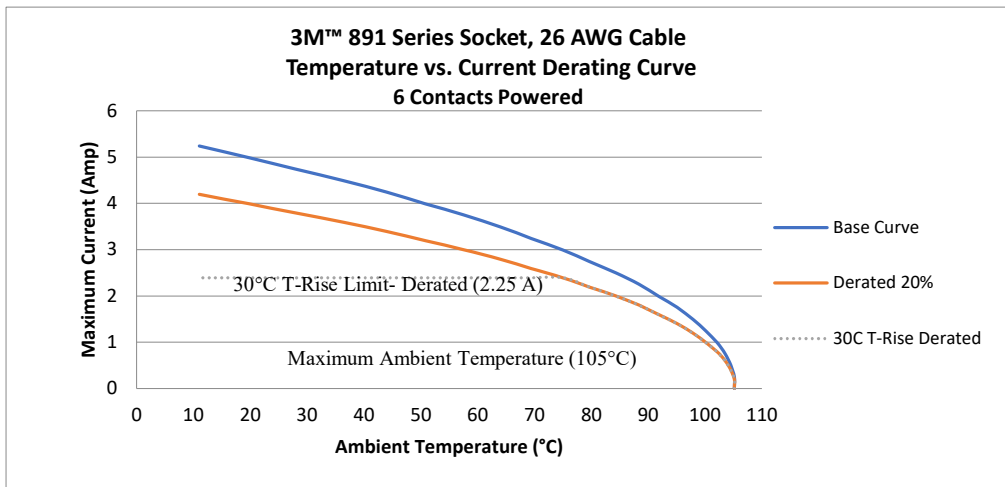
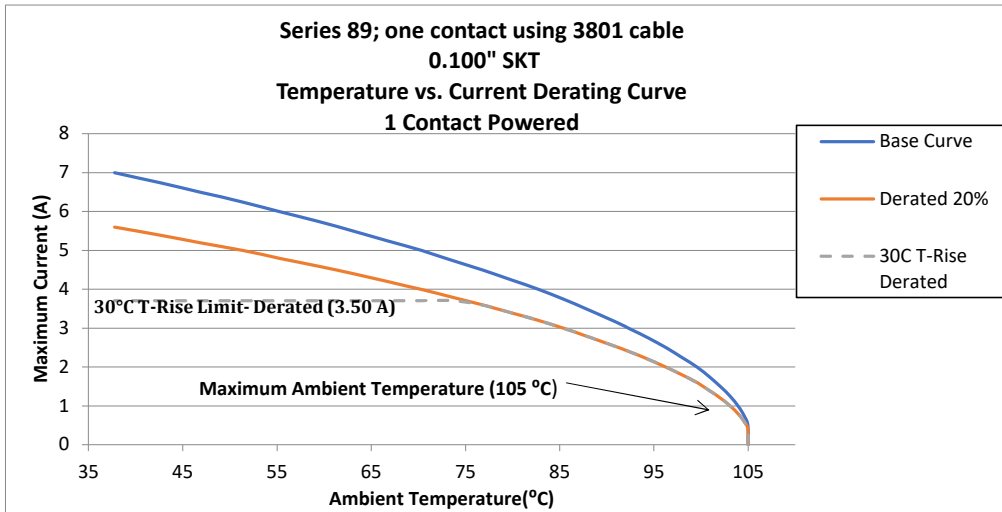
**9.2 Independent Tests**

1. Plating Thicknesses
2. Header Solderability
3. Header Moisture Sensitivity Level
4. Header Pin Retention
5. Dielectric Withstanding Voltage
6. Current Rating
7. Insulation Resistance
8. Mating Force / Contact
9. Unmating Force / Contact
10. Latch Retention Force

10. Figures

10.1 Current Rating





**11. Agency Listings**

**11.1 Underwriters Laboratories (UL)**

Agency	File No.
UL	E68080
CUL	E68080

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